# NTGS3447P

# **Power MOSFET**

# -12 V, -5.3 A, Single P-Channel, TSOP-6

### **Features**

- Low R<sub>DS(on)</sub> in TSOP-6 Package
- 1.8 V Gate Rating
- This is a Pb-Free Device

### **Applications**

- Battery Switch and Load Management Applications in Portable Equipment
- High Side Load Switch
- PA Switch

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	$V_{DSS}$	-12	٧		
Gate-to-Source Voltage	9		V <sub>GS</sub>	±8	V
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-4.7	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C	]	-3.4	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-5.3	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.25	W
	t ≤ 5 s			1.6	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-3.4	Α
Current (Note 2)	State	T <sub>A</sub> = 85°C	1	-2.5	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.7	W
Pulsed Drain Current	t <sub>p</sub> =	= 10 μs	I <sub>DM</sub>	-19	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

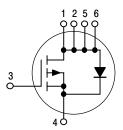


## ON Semiconductor®

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
-12 V	40 mΩ @ -4.5 V	-4.7 A	
	53 mΩ @ -2.5 V	-4.1 A	
	72 mΩ @ -1.8 V	-2.0 A	

### P-Channel



### MARKING DIAGRAM



TSOP-6 CASE 318G STYLE 1



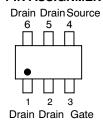
SE = Device Code

M = Date Code

Pb-Free Package

(Note: Microdot may be in either location)

### **PIN ASSIGNMENT**



# ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>		
NTGS3447PT1G	TSOP-6 (Pb-Free)	3000 / Tape & Reel		

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	100	
Junction-to-Ambient – $t \le 5 s$ (Note 3)	$R_{ hetaJA}$	78	°C/W
Junction-to-Ambient - Minimum Pad (Note 4)	$R_{ hetaJA}$	188	

<sup>3.</sup> Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
4. Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0775 in sq).

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$		-12			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			-1.0	μΑ
		V <sub>DS</sub> = -12 V	T <sub>J</sub> = 85°C			-5.0	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$				±0.1	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= -250 μΑ	-0.45		-1.0	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -4.7 \text{ A}$			30	40	mΩ
		V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = -4.1 A			40	53	
		V <sub>GS</sub> = -1.8 V, I <sub>D</sub> = -2.0 A			53	72	
Forward Transconductance	9FS	V <sub>DS</sub> = −5 V, I <sub>D</sub>	<sub>0</sub> = -4.7 A		12		S
CHARGES, CAPACITANCES AND GATE F	RESISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = -6 V			1053		pF
Output Capacitance	C <sub>OSS</sub>				254		
Reverse Transfer Capacitance	C <sub>RSS</sub>				129		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -6 \text{ V};$ $I_D = -4.7 \text{ A}$			10.4	15	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.0		
Gate-to-Source Charge	$Q_{GS}$				1.7		
Gate-to-Drain Charge	$Q_{GD}$				0.4		
SWITCHING CHARACTERISTICS, $V_{GS} = 4$	I.5 V (Note 6)						
Turn-On Delay Time	t <sub>d(ON)</sub>				7	11	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, \	$I_{DS} = -6 \text{ V},$		14	22	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = -1.0 \text{ A}, R_G = 6.0 \Omega$			78	117	
Fall Time	t <sub>f</sub>				47	71	
DRAIN-SOURCE DIODE CHARACTERIST	ics						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -1.7 A	T <sub>J</sub> = 25°C		-0.7	-1.2	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dl_{SD}/d_t = 100 \text{ A/}\mu\text{s,}$ $l_S = -1.7 \text{ A}$			33	66	ns

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%
6. Switching characteristics are independent of operating junction temperatures

## TYPICAL PERFORMANCE CURVES ( $T_J = 25^{\circ}$ C unless otherwise noted)

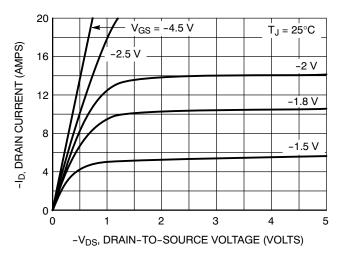


Figure 1. On-Region Characteristics

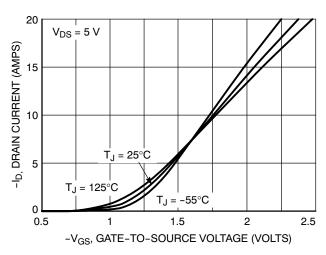


Figure 2. Transfer Characteristics

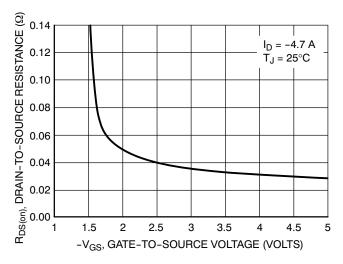


Figure 3. On-Resistance vs. Gate-to-Source Voltage

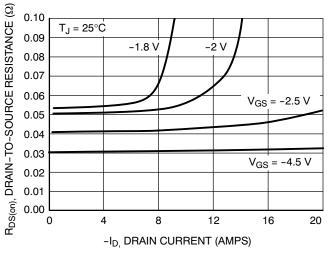


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

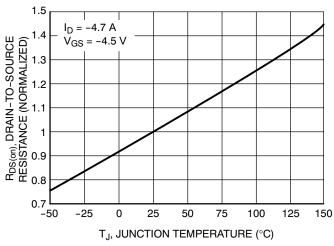


Figure 5. On–Resistance Variation with Temperature

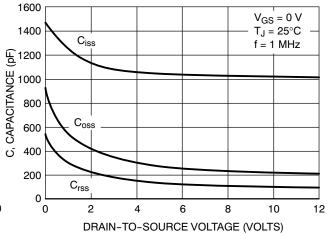


Figure 6. Capacitance Variation

# TYPICAL PERFORMANCE CURVES ( $T_J = 25^{\circ}C$ unless otherwise noted)

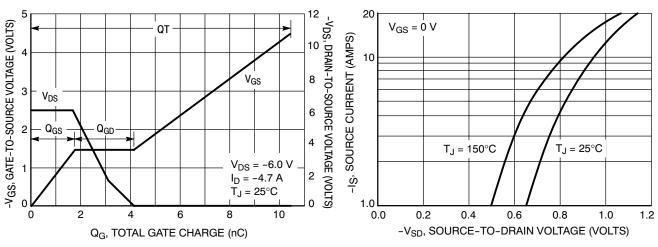


Figure 7. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

Figure 8. Diode Forward Voltage vs. Current

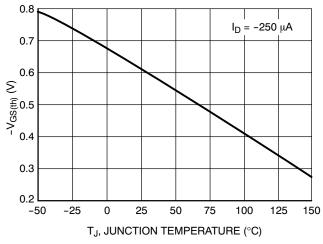


Figure 9. Threshold Voltage

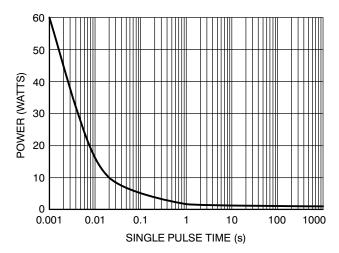


Figure 10. Single Pulse Maximum Power Dissipation

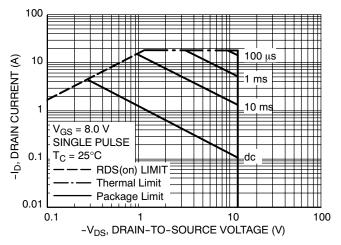


Figure 11. Maximum Rated Forward Biased Safe Operating Area

## NTGS3447P

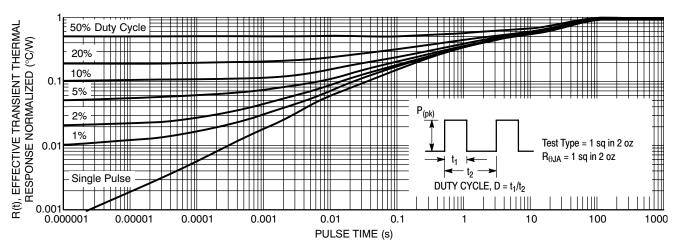
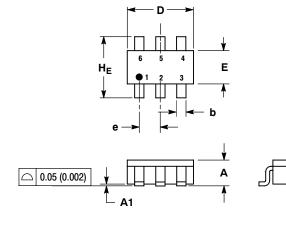


Figure 12. FET Thermal Response

## NTGS3447P

### PACKAGE DIMENSIONS

### TSOP-6 CASE 318G-02 ISSUE S





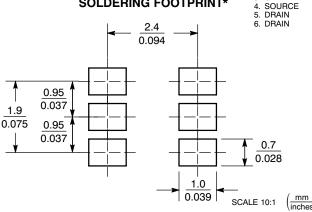
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
  DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.90	1.00	1.10	0.035	0.039	0.043	
A1	0.01	0.06	0.10	0.001	0.002	0.004	
b	0.25	0.38	0.50	0.010	0.014	0.020	
O	0.10	0.18	0.26	0.004	0.007	0.010	
О	2.90	3.00	3.10	0.114	0.118	0.122	
П	1.30	1.50	1.70	0.051	0.059	0.067	
е	0.85	0.95	1.05	0.034	0.037	0.041	
٦	0.20	0.40	0.60	0.008	0.016	0.024	
ΗE	2.50	2.75	3.00	0.099	0.108	0.118	
θ	0°	-	10°	0°	-	10°	

STYLE 1

PIN 1. DRAIN 2. DRAIN 3. GATE

- SOURCE DRAIN



**SOLDERING FOOTPRINT\*** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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